

Search Notes

Application/Control No.

10/786,954

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

TINCKNELL ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	136.1	2/13/2006	DB
	140.1		
	295.2		
	296.1		
	285.1		
	423		
	921		
29	890.14		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner